

TA Technology (Shanghai) Co., Ltd.
Test Report

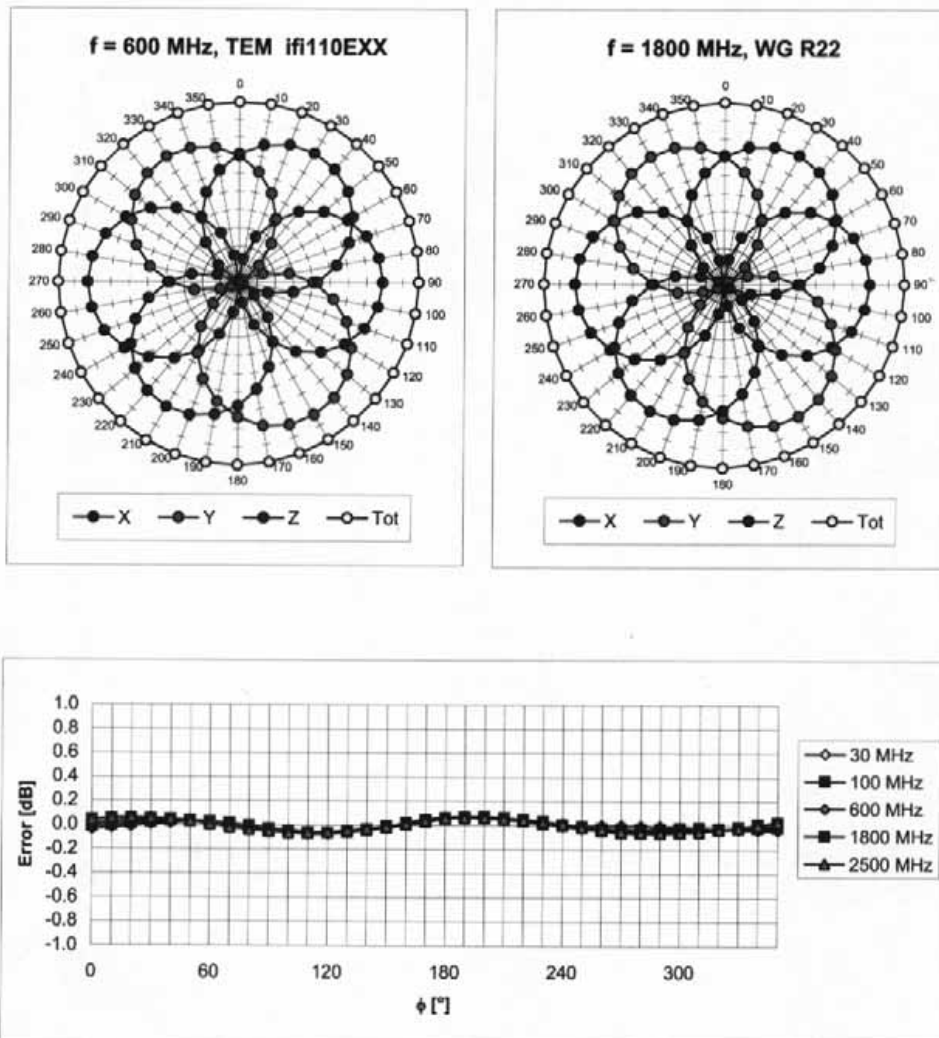
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ET3DV6 SN:1737

November 25, 2008

Receiving Pattern (ϕ), $\theta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

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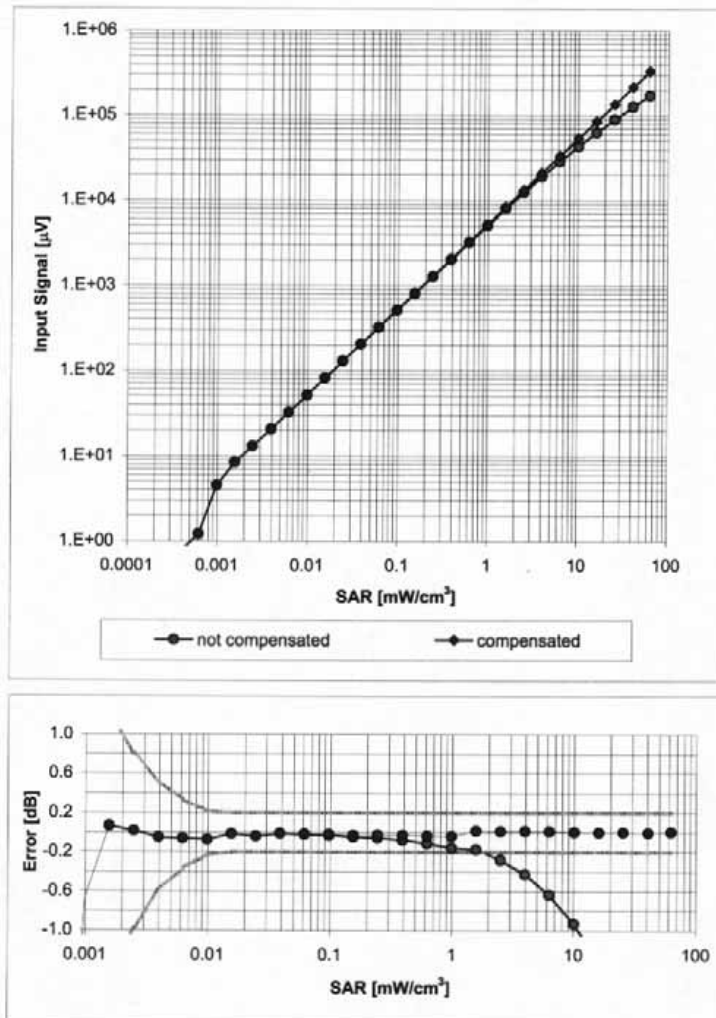
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ET3DV6 SN:1737

November 25, 2008

Dynamic Range $f(\text{SAR}_{\text{head}})$
(Waveguide R22, $f = 1800 \text{ MHz}$)

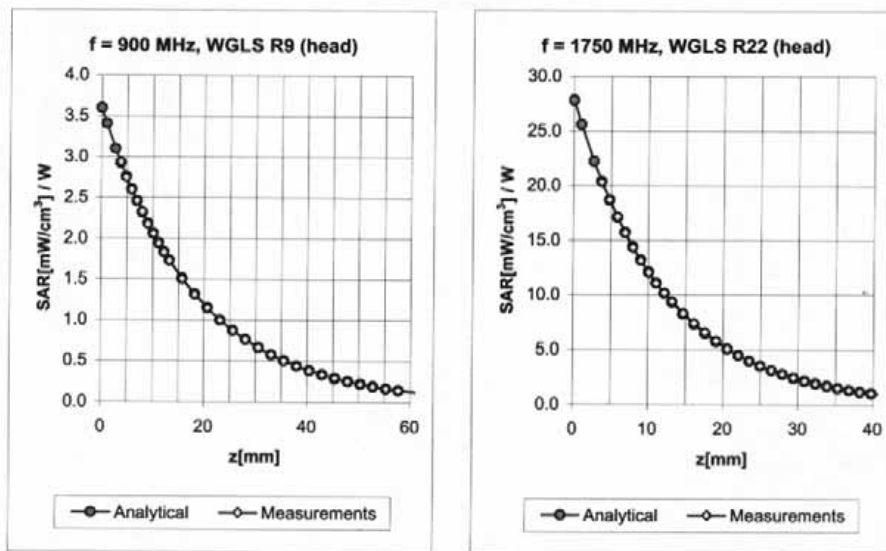


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

ET3DV6 SN:1737

November 25, 2008

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
450	± 50 / ± 100	Head	43.5 ± 5%	0.87 ± 5%	0.36	1.84	7.20 ± 13.3% (k=2)
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.25	3.53	6.33 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.27	3.53	6.14 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.56	2.77	5.35 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.57	2.72	4.89 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.51	1.60	4.39 ± 11.0% (k=2)
450	± 50 / ± 100	Body	56.7 ± 5%	0.94 ± 5%	0.27	1.80	7.52 ± 13.3% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.36	2.75	6.14 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.43	2.51	5.98 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.99	1.74	4.84 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.99	1.50	4.60 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.98	1.42	3.91 ± 11.0% (k=2)

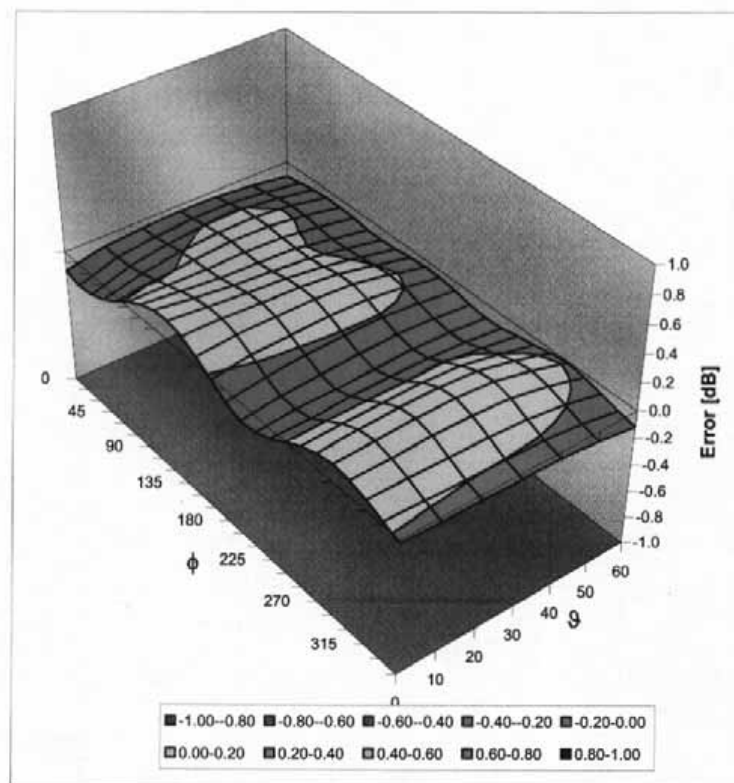
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

ET3DV6 SN:1737

November 25, 2008

Deviation from Isotropy in HSL

Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

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ANNEX E: D835V2 Dipole Calibration Certificate

信息产业部通信计量中心
Telecommunication Metrology Center of MII



Client

TA

Certificate No: D835V2-4d020_Jul09

检测
CNAS L0442

CALIBRATION CERTIFICATE

Object D835V2 - SN: 4d020

Calibration Procedure(s) TMC-XZ-01-027
Calibration procedure for dipole validation kits

Calibration date: July 15, 2009

Condition of the calibrated item In Tolerance

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)℃ and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRVD	101253	19-Jun-09 (TMC, No.JZ09-248)	Jun-10
Power sensor NRV-Z5	100333	19-Jun-09 (TMC, No. JZ09-248)	Jun-10
Reference Probe ES3DV3	SN 3149	08-Dec-08(SPEAG, No.ES3-3149_Dec08)	Dec-09
DAE4	SN 771	21-Nov-08(SPEAG, No.DAE4-771_Nov08)	Nov-09
RF generator E4438C	MY45092879	18-Jun-09(TMC, No.JZ09-302)	Jun-10
Network Analyzer 8753E	US38433212	03-Aug-08(TMC, No.JZ08-056)	Aug-09

	Name	Function	Signature
Calibrated by:	Lin Hao	SAR Test Engineer	
Reviewed by:	Qi Dianyuan	SAR Project Leader	
Approved by:	Lu Bingsong	Deputy Director of the laboratory	

Issued: July 15, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratoty.

Certificate No: D835V2-4d020_Jul09

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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM _{x,y,z}
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	2mm Oval Phantom ELI4	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz $\pm$ 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	41.2 $\pm$ 6 %	0.91 mho/m $\pm$ 6 %
Head TSL temperature during test	(21.7 $\pm$ 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.40 mW / g
SAR normalized	normalized to 1W	9.60 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	9.2 mW / g $\pm$ 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	1.55 mW / g
SAR normalized	normalized to 1W	6.20 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	6.07 mW / g $\pm$ 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2	0.97 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	54.6 ± 6%	0.99mho/m ± 6 %
Body TSL temperature during test	(21.9 ± 0.2) °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm^3 (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.41 mW / g
SAR normalized	normalized to 1W	9.64 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	9.28 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm^3 (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	1.58 mW / g
SAR normalized	normalized to 1W	6.32 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	6.19 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	53.7Ω -3.7 jΩ
Return Loss	- 25.9dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	49.4Ω - 5.1 jΩ
Return Loss	-25.6dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.387 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	April 22, 2004

DASY5 Validation Report for Head TSL

Certificate No: D835V2-4d020_Jul09

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Date/Time: 2009-7-15 14:54:13

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Head 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.91 \text{ mho/m}$; $\epsilon_r = 41.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.34, 6.34, 6.34); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

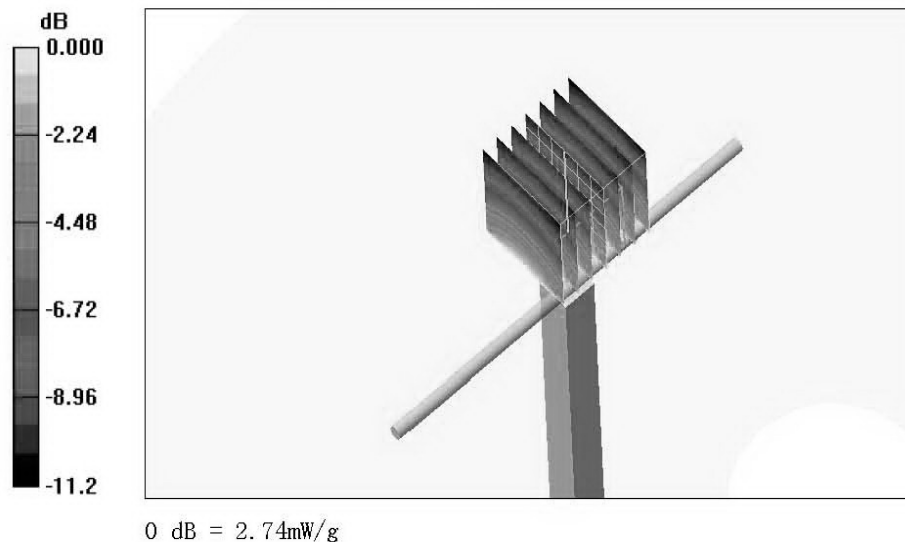
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 55.2 V/m; Power Drift = -0.019 dB

Peak SAR (extrapolated) = 3.16 W/kg

SAR(1 g) = 2.4 mW/g; SAR(10 g) = 1.55 mW/g

Maximum value of SAR (measured) = 2.74 mW/g

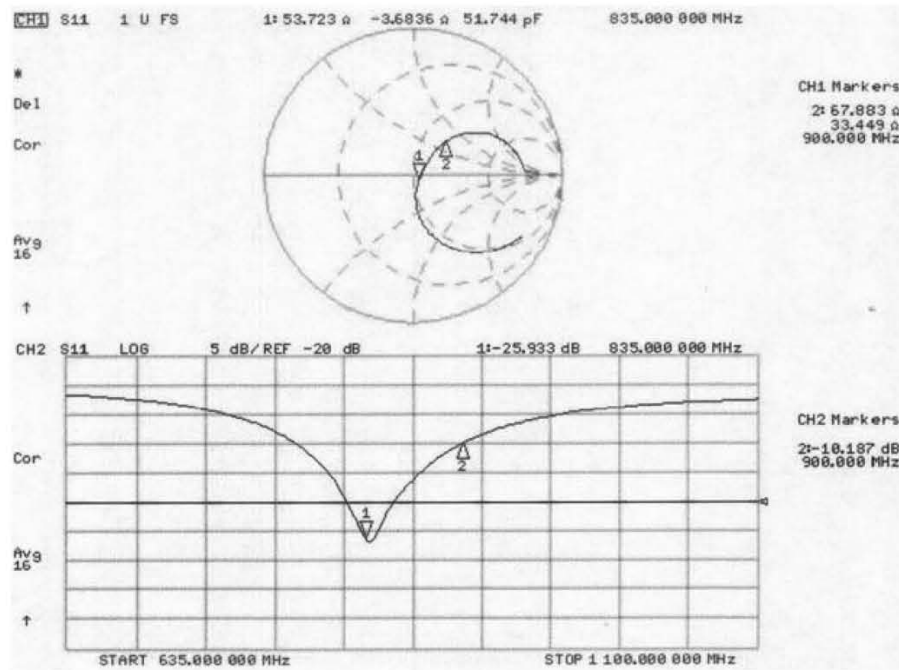


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Impedance Measurement Plot for Head TSL



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DASY5 Validation Report for Body TSL

Date/Time: 2009-7-15 11:27:23

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Body 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.99 \text{ mho/m}$; $\epsilon_r = 54.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.02, 6.02, 6.02); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

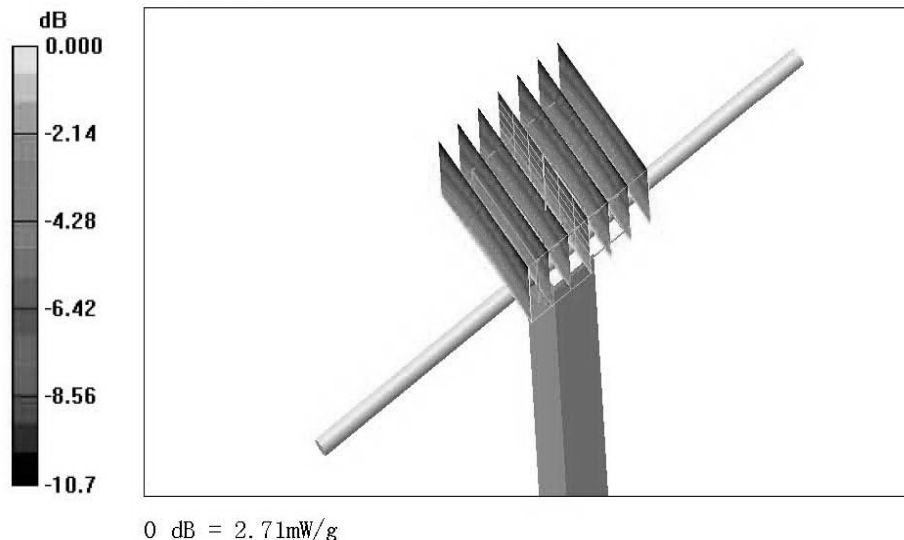
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 54.1 V/m ; Power Drift = -0.004 dB

Peak SAR (extrapolated) = 3.81 W/kg

SAR(1 g) = 2.41 mW/g; SAR(10 g) = 1.58 mW/g

Maximum value of SAR (measured) = 2.71 mW/g

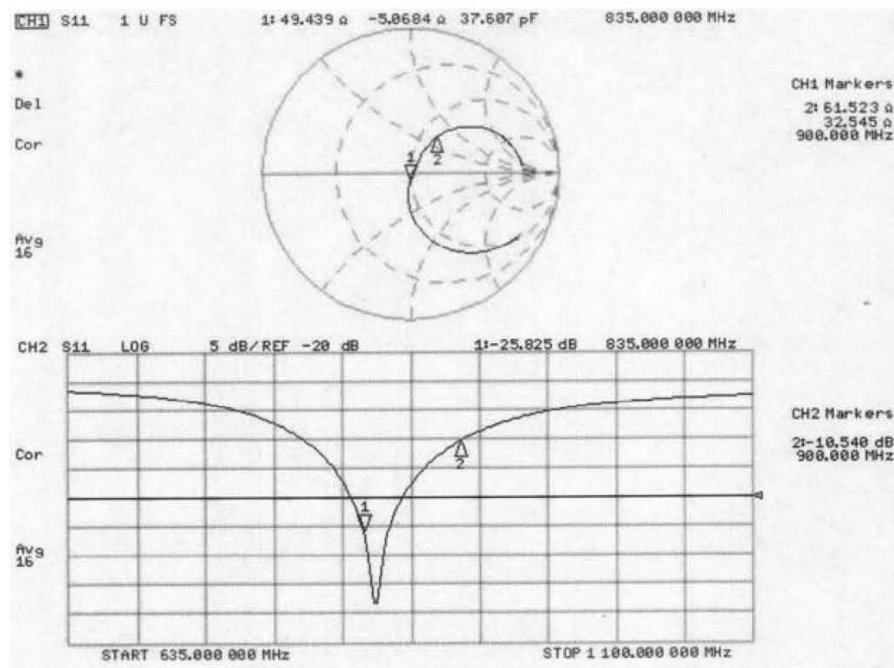


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Impedance Measurement Plot for Body TSL

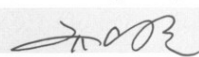
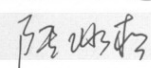


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ANNEX F: D1900V2 Dipole Calibration Certificate

信息产业部通信计量中心 Telecommunication Metrology Center of MII		TMC	ILAC-MRA	CNAS																												
Client	TA	Certificate No: D1900V2-5d060_Jul09																														
CALIBRATION CERTIFICATE																																
Object	D1900V2 - SN: 5d060																															
Calibration Procedure(s)	TMC-XZ-01-027 Calibration procedure for dipole validation kits																															
Calibration date:	July 15, 2009																															
Condition of the calibrated item	In Tolerance																															
This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)℃ and humidity<70%. Calibration Equipment used (M&TE critical for calibration) <table border="1"><thead><tr><th>Primary Standards</th><th>ID #</th><th>Cal Date(Calibrated by, Certificate No.)</th><th>Scheduled Calibration</th></tr></thead><tbody><tr><td>Power Meter NRVD</td><td>101253</td><td>19-Jun-09 (TMC, No. JZ09-248)</td><td>Jun-10</td></tr><tr><td>Power sensor NRV-Z5</td><td>100333</td><td>19-Jun-09 (TMC, No. JZ09-248)</td><td>Jun-10</td></tr><tr><td>Reference Probe ES3DV3</td><td>SN 3149</td><td>08-Dec-08(SPEAG, No.ES3-3149_Dec08)</td><td>Dec-09</td></tr><tr><td>DAE4</td><td>SN 771</td><td>21-Nov-08(SPEAG, No.DAE4-771_Nov08)</td><td>Nov-09</td></tr><tr><td>RF generator E4438C</td><td>MY45092879</td><td>18-Jun-09(TMC, No.JZ09-302)</td><td>Jun-10</td></tr><tr><td>Network Analyzer 8753E</td><td>US38433212</td><td>03-Aug-08(TMC, No.JZ08-056)</td><td>Aug-09</td></tr></tbody></table>					Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration	Power Meter NRVD	101253	19-Jun-09 (TMC, No. JZ09-248)	Jun-10	Power sensor NRV-Z5	100333	19-Jun-09 (TMC, No. JZ09-248)	Jun-10	Reference Probe ES3DV3	SN 3149	08-Dec-08(SPEAG, No.ES3-3149_Dec08)	Dec-09	DAE4	SN 771	21-Nov-08(SPEAG, No.DAE4-771_Nov08)	Nov-09	RF generator E4438C	MY45092879	18-Jun-09(TMC, No.JZ09-302)	Jun-10	Network Analyzer 8753E	US38433212	03-Aug-08(TMC, No.JZ08-056)	Aug-09
Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration																													
Power Meter NRVD	101253	19-Jun-09 (TMC, No. JZ09-248)	Jun-10																													
Power sensor NRV-Z5	100333	19-Jun-09 (TMC, No. JZ09-248)	Jun-10																													
Reference Probe ES3DV3	SN 3149	08-Dec-08(SPEAG, No.ES3-3149_Dec08)	Dec-09																													
DAE4	SN 771	21-Nov-08(SPEAG, No.DAE4-771_Nov08)	Nov-09																													
RF generator E4438C	MY45092879	18-Jun-09(TMC, No.JZ09-302)	Jun-10																													
Network Analyzer 8753E	US38433212	03-Aug-08(TMC, No.JZ08-056)	Aug-09																													
Calibrated by:	Name Lin Hao	Function SAR Test Engineer	Signature 																													
Reviewed by:	Qi Dianyuan	SAR Project Leader																														
Approved by:	Lu Bingsong	Deputy Director of the laboratory																														
Issued: July 15, 2009																																
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.																																

Certificate No: D1900V2-5d060_Jul09

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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM _{x,y,z}
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	2mm Oval Phantom ELI4	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz $\pm$ 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	39.6 $\pm$ 6 %	1.40mho/m $\pm$ 6 %
Head TSL temperature during test	(21.9 $\pm$ 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	9.88 mW / g
SAR normalized	normalized to 1W	39.5 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	37.8 mW / g $\pm$ 17.0 % (k=2)

SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	5.0 mW / g
SAR normalized	normalized to 1W	20.0 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	19.8 mW / g $\pm$ 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.9 ± 6%	1.55 mho/m ± 6 %
Body TSL temperature during test	(21.8 ± 0.2) °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm^3 (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	10.2 mW / g
SAR normalized	normalized to 1W	40.8 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	39.4 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm^3 (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	5.18 mW / g
SAR normalized	normalized to 1W	20.72 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	21.0 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	$54.8\Omega + 4.0 j\Omega$
Return Loss	- 23.7dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	$47.9\Omega + 7.1 j\Omega$
Return Loss	- 22.6dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.201 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	December 10, 2004

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DASY5 Validation Report for Head TSL

Date/Time: 2009-7-15 14:15:30

Test Laboratory: TMC, Beijing, China

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: SN: 5d060

Communication System: CW Frequency: 1900 MHz Duty Cycle: 1:1

Medium: Head 1900MHz

Medium parameters used: $f = 1900 \text{ MHz}$; $\sigma = 1.40 \text{ mho/m}$; $\epsilon_r = 39.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(5.18, 5.18, 5.18); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=10mm/Zoom Scan (7x7x7)/Cube 0:

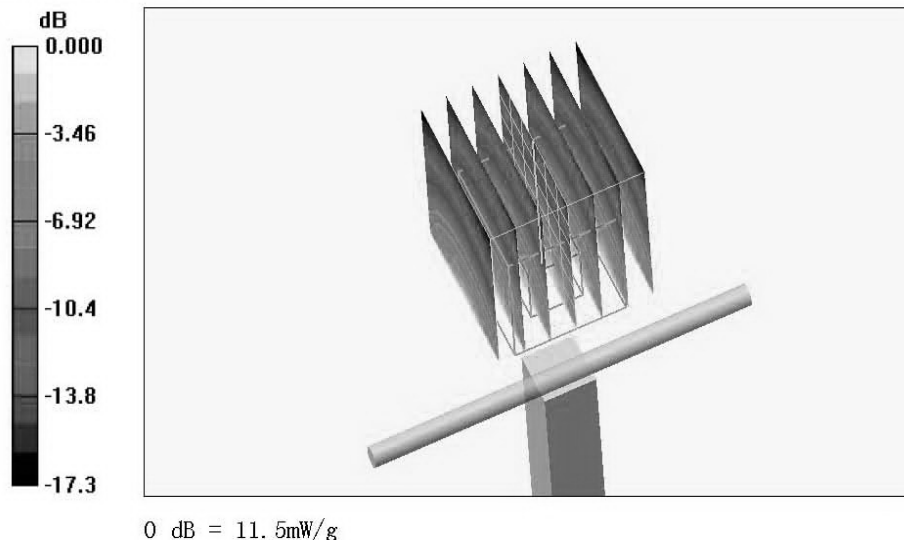
Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$

Reference Value = 85.1 V/m ; Power Drift = -0.057 dB

Peak SAR (extrapolated) = 18.8 W/kg

SAR(1 g) = 9.88 mW/g; SAR(10 g) = 5.0 mW/g

Maximum value of SAR (measured) = 11.5 mW/g

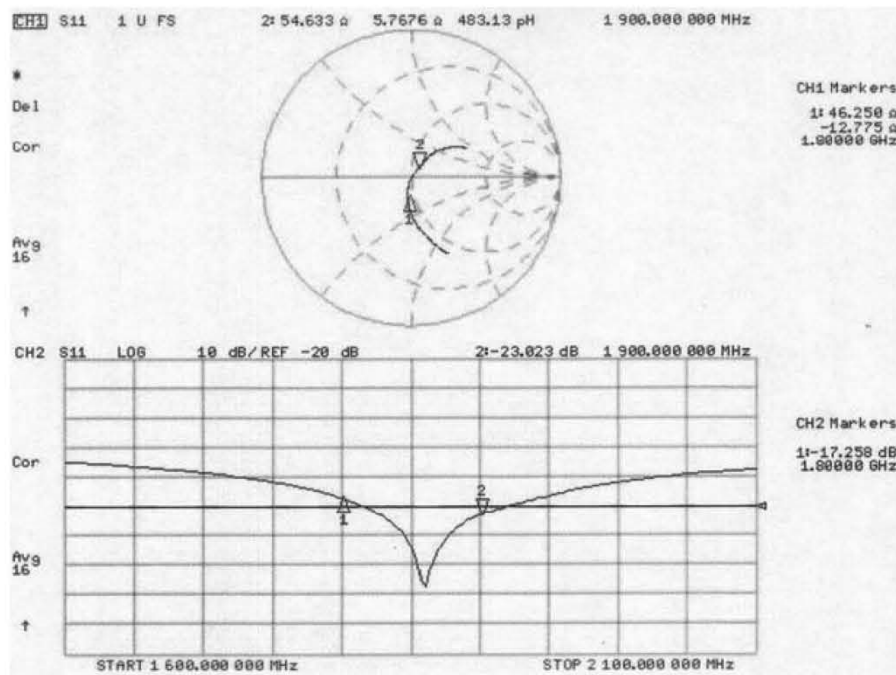


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Impedance Measurement Plot for Head TSL



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DASY5 Validation Report for Body TSL

Date/Time: 2009-7-15 15:37:31

Test Laboratory: TMC, Beijing, China

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: SN: 5d060

Communication System: CW Frequency: 1800 MHz Duty Cycle: 1:1

Medium: Body 1900MHz

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.55$ mho/m; $\epsilon_r = 52.9$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(4.97, 4.97, 4.97); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=10mm/Zoom Scan (7x7x7)/Cube 0:

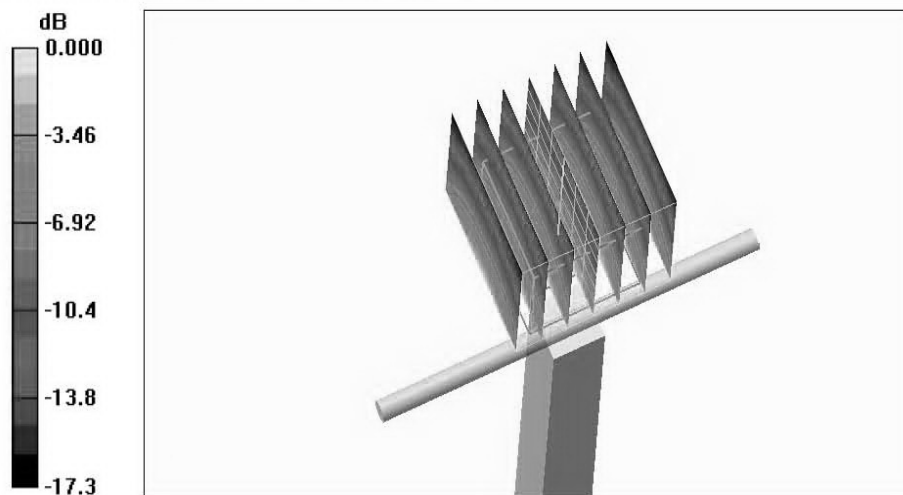
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 79.6 V/m; Power Drift = -0.009 dB

Peak SAR (extrapolated) = 19.1 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.18 mW/g

Maximum value of SAR (measured) = 11.9 mW/g



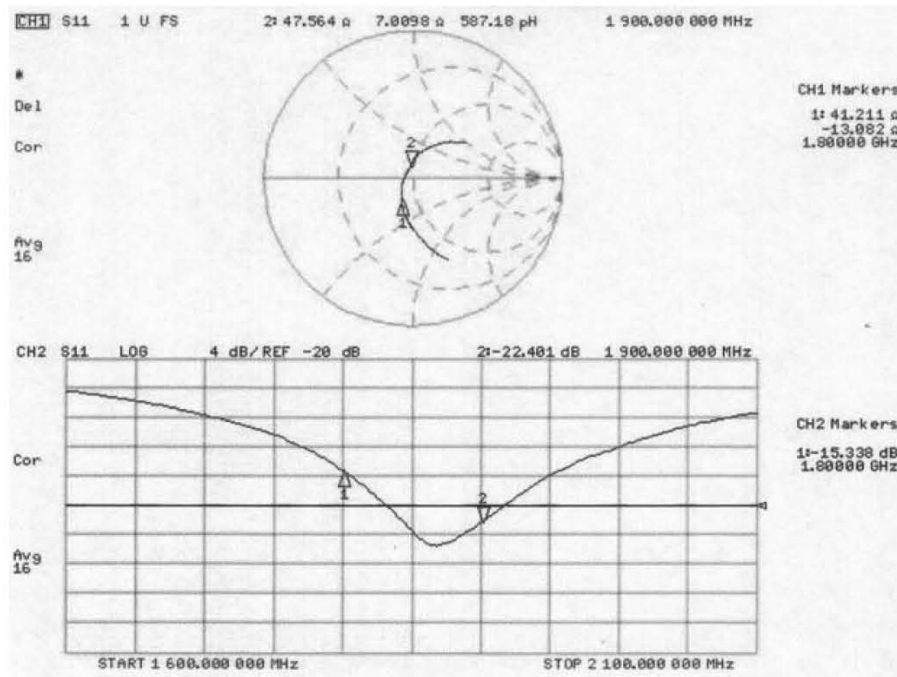
0 dB = 11.9mW/g

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Impedance Measurement Plot for Body TSL



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ANNEX G: DAE4 Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client **Auden**

Certificate No: DAE4-452_Nov08

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 452**

Calibration procedure(s) **QA CAL-06.v12
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **November 18, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	30-Sep-08 (No: 7673)	Sep-09
Keithley Multimeter Type 2001	SN: 0810278	30-Sep-08 (No: 7670)	Sep-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	06-Jun-08 (in house check)	In house check: Jun-09

Calibrated by:	Name Dominique Steffen	Function Technician	Signature
Approved by:	Fin Bornholt	R&D Director	

Issued: November 18, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-452_Nov08

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61 nV, full range = -1.....+3 mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.585 $\pm$ 0.1% (k=2)	404.416 $\pm$ 0.1% (k=2)	404.565 $\pm$ 0.1% (k=2)
Low Range	3.97854 $\pm$ 0.7% (k=2)	3.95135 $\pm$ 0.7% (k=2)	3.98063 $\pm$ 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	148 ° $\pm$ 1 °
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Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	200000	0.00
Channel X + Input	20000	20006.89	0.03
Channel X - Input	20000	-20003.71	0.02
Channel Y + Input	200000	200000.5	0.00
Channel Y + Input	20000	20008.05	0.04
Channel Y - Input	20000	-20006.61	0.03
Channel Z + Input	200000	199999.6	0.00
Channel Z + Input	20000	20006.84	0.03
Channel Z - Input	20000	-20004.66	0.02

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.19	0.09
Channel X - Input	200	-199.99	0.00
Channel Y + Input	2000	2000	0.00
Channel Y + Input	200	199.38	-0.31
Channel Y - Input	200	-200.73	0.36
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.25	-0.38
Channel Z - Input	200	-201.52	0.76

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	2.99	1.90
	- 200	-1.54	-1.85
Channel Y	200	-8.82	-8.73
	- 200	6.90	6.96
Channel Z	200	9.94	10.21
	- 200	-13.53	-13.21

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.31	-0.98
Channel Y	200	1.52	-	2.97
Channel Z	200	-1.16	0.18	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16123	16646
Channel Y	15886	16452
Channel Z	16175	16346

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.53	-0.80	1.64	0.33
Channel Y	-1.51	-2.67	-0.89	0.35
Channel Z	-1.99	-3.07	-1.43	0.29

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	198.3
Channel Y	0.1999	200.1
Channel Z	0.1999	199.3

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

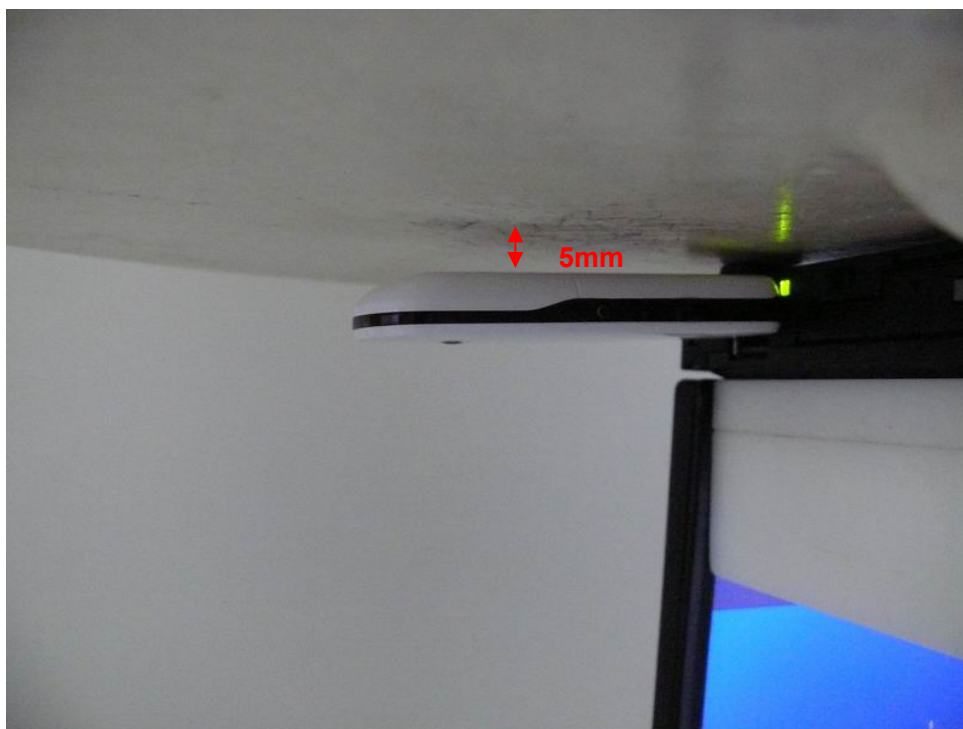
9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

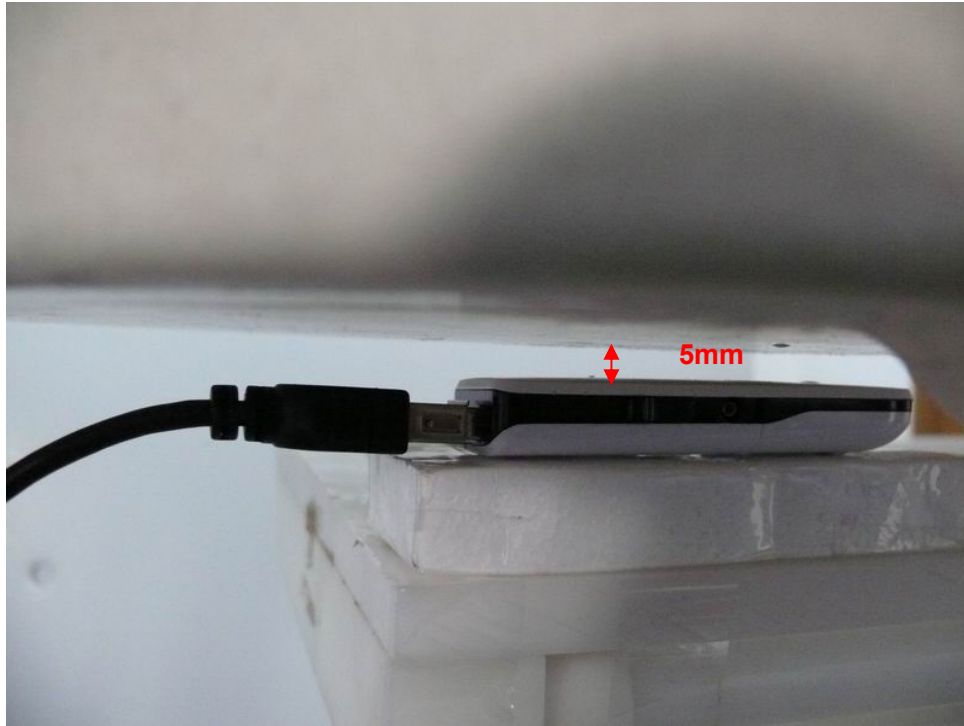
ANNEX H: The EUT Appearances and Test Configuration



Picture 5: Constituents of the EUT



6-a: Test position 1



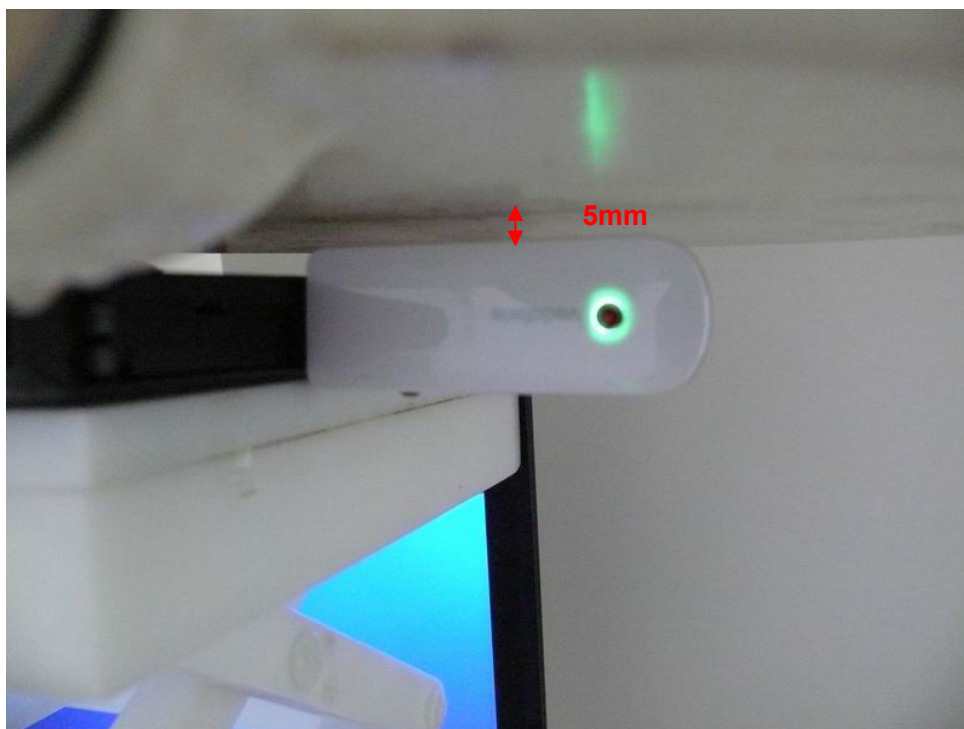
6-b: Test position 2



6-c: Test position 3



6-d: Test position 4



6-e: Test position 5

Picture 6: Different Test Position